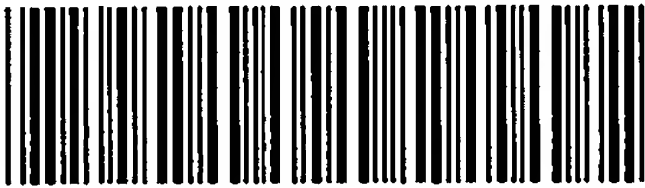


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/626,096	LEE ET AL.	
	Examiner	Art Unit	
	DAVID VU	2818	

SEARCHED			
Class	Subclass	Date	Examiner
438	201, 211; 257, 260; 264, 482	2/16/2005	DV
	486	2/16/2005	DV
257	314-316	2/16/2005	DV
	239	2/16/2005	DV

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST	2/16/2005	DV
EAST	2/16/2005	DV